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- Meets or Exceeds the EIA Standards RS-422-A, RS-423-A, RS-485, and CCITT Recommendation V.11
- Designed to Operate With Pulse Durations as Short as 20 ns
- Designed for Multipoint Transmission on Long Bus Lines in Noisy Environments
- Input Sensitivity . . . ±200 mV
- Low-Power Consumption . . . 20 mA Max
- Open-Circuit Fail-Safe Design
- Common-Mode Input Voltage Range of -7 V to 12 V
- Pin Compatible With SN75175 and LTC489

#### description

The SN65LBC175 and SN75LBC175 are monolithic, quadruple, differential line receivers with 3-state outputs designed to meet the requirements of the EIA standards RS-422-A, RS-423-A, RS-485, and CCITT Recommendation V.11. The devices are optimized for balanced multipoint bus transmission at data rates up to and exceeding 10 million bits per second. The receivers are enabled in pairs, with an active-high enable input. Each differential receiver input features high impedance, hysteresis for increased noise immunity, and sensitivity of ±200 mV over a common-mode input voltage range of 12 V to −7 V. The fail-safe design ensures that when the inputs are open-circuited, the outputs are always high. Both devices are designed using the TI proprietary LinBiCMOS<sup>™</sup> technology allowing low power consumption, high switching speeds, and robustness.

These devices offer optimum performance when used with the SN75LBC172 or SN75LBC174 quadruple line drivers. The SN65LBC175 is available in the 16-pin DIP (N), small-outline package (D), and the wide small-outline package (DW). The SN75LBC175 is available in the 16-pin DIP (N) and the small-outline package (D).

The SN65LBC175 is characterized over the industrial temperature range of  $-40^{\circ}$ C to  $85^{\circ}$ C. The SN75LBC175 is characterized for operation over the commercial temperature range of  $0^{\circ}$ C to  $70^{\circ}$ C.

DAOKAOE	TEMPERATURE RANGE								
PACKAGE	0°C to 70°C	–40°C to 85°C							
SOIC	SN75LBC175D	SN65LBC175D							
Wide SOIC	—	SN65LBC175DW							
PDIP	SN75LBC175N	SN65LBC175N							

AVAILABLE OPTIONS



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PRODUCTION DATA information is current as of publication date. Products conform to specifications per the terms of Texas Instruments standard warranty. Production processing does not necessarily include testing of all parameters.



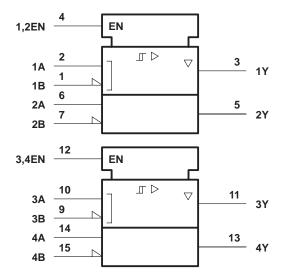
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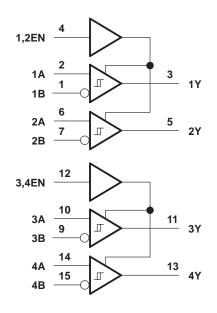
D, DW, OR N PACKAGE (TOP VIEW)										
			L							
1B [	1	16	] V <sub>CC</sub> ] 4B							
1A [	2	15	] 4B							
1Y 🛛	3	14	] 4A							
1,2EN	4	13	] 4Y							
2Y [	5	12	] 3,4EN							
2A 🛛	6	11	] 3Y							
2B 🛛	7	10	] 3A							
GND [	8	9	] 3B							

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#### logic symbol<sup>†</sup>



logic diagram (positive logic)



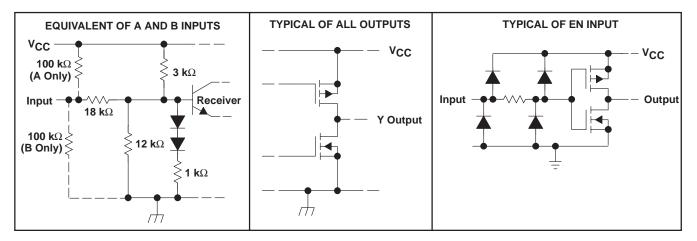
<sup>†</sup> This symbol is in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12.

FUNCTION TABLE
(each receiver)

(each receiver)									
DIFFERENTIAL INPUTS A-B	ENABLE	OUTPUT Y							
$V_{ID} \ge 0.2 V$	Н	Н							
$-0.2 \text{ V} < \text{V}_{\text{ID}} < 0.2 \text{ V}$	Н	?							
$V_{ID} \le -0.2 V$	Н	L							
Х	L	Z							
Open circuit	Н	Н							

H = high level, L = low level, X = irrelevant,Z = high impedance (off), ? = indeterminate

#### schematics of inputs and outputs





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#### absolute maximum ratings over operating free-air temperature range (unless otherwise noted)<sup>†</sup>

Supply voltage range, V <sub>CC</sub> (see Note 1)	±25 V
Differential input voltage, V <sub>ID</sub> (see Note 2)	
Continuous total dissipation	00
Operating free-air temperature range, T <sub>A</sub> : SN65LBC175	1 3
SN75LBC175	0°C to 70°C
Storage temperature range, T <sub>stg</sub>	–65°C to 150°C
Electrostatic Discharge (ESD): Human Body Model (HBM)	1 kV
Machine Model (MM)	
Charged Device Model (CDM)	

<sup>†</sup> Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

NOTES: 1. All voltage values are with respect to GND.

2. Differential input voltage is measured at the noninverting input with respect to the corresponding inverting input.

### DISSIPATION RATING TABLE

PACKAGE	T <sub>A</sub> ≤ 25°C POWER RATING	A		T <sub>A</sub> = 85°C POWER RATING
D	1100 mW	8.7 mW/°C	709 mW	578 mW
DW	1200 mW	9.6 mW/°C	770 mW	625 mW
N	1150 mW	9.2 mW/°C	736 mW	598 mW

#### recommended operating conditions

			MIN	NOM	MAX	UNIT
Supply voltage, V <sub>CC</sub>			4.75	5	5.25	V
Common-mode input voltage, VIC			-7		12	V
Differential input voltage, VID					±6	V
High-level input voltage, VIH	Ebligante		2			V
Low-level input voltage, VIL	EN inputs				0.8	V
High-level output current, IOH					-8	mA
Low-level output current, IOL					8	mA
	SN65LBC1	75	-40		85	° <b>0</b>
Operating free-air temperature, T <sub>A</sub>	SN75LBC1	75	0		70	°C



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# electrical characteristics over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted)

PARAMETER			ТІ	MIN	TYP†	MAX	UNIT		
$V_{IT+}$	Positive-going input three	shold voltage	$I_{O} = -8 \text{ mA}$					0.2	V
VIT-	Negative-going input three	eshold voltage	IO = 8 mA			-0.2			V
V <sub>hys</sub>	Hysteresis voltage (VIT.	+ - VIT_)					45		mV
VIK	Enable input clamp volta	ge	lı = – 18 mA				-0.9	-1.5	V
۷он	High-level output voltage	•	V <sub>ID</sub> = 200 mV,	IOH = -8 m	A	3.5	4.5		V
VOL	Low-level output voltage		$V_{ID} = -200 \text{ mV},$	I <sub>OL</sub> = 8 mA			0.3	0.5	V
I <sub>OZ</sub>	High-impedance-state or	utput current	$V_{O} = 0 V$ to $V_{CC}$					±20	μA
			V <sub>IH</sub> = 12 V,	V <sub>CC</sub> = 5 V,	Other inputs at 0 V		0.7	1	
			V <sub>IH</sub> = 12 V,	$V_{CC} = 0 V,$	Other inputs at 0 V		0.8	1	
I	Bus input current	A or B inputs	$V_{IH} = -7 V$ ,	V <sub>CC</sub> = 5 V,	Other inputs at 0 V		-0.5	-0.8	mA
			$V_{IH} = -7 V$ ,	$V_{CC} = 0 V,$	Other inputs at 0 V		-0.4	-0.8	
IIН	High-level enable input of	urrent	V <sub>IH</sub> = 5 V					±20	μA
١ <sub>١L</sub>	Low-level enable input c	urrent	V <sub>IL</sub> = 0 V					-20	μΑ
los	Short-circuit output curre	ent	$V_{O} = 0$				-80	-120	mA
	Cumply summat		Outputs enabled,	I <sub>O</sub> = 0,	V <sub>ID</sub> = 5 V		11	20	
ICC	Supply current		Outputs disabled				0.9	1.4	mA

<sup>†</sup> All typical values are at  $V_{CC} = 5$  V and  $T_A = 25^{\circ}C$ .

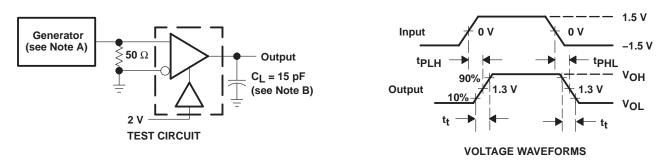
### switching characteristics, V<sub>CC</sub> = 5 V, C<sub>L</sub> = 15 pF, T<sub>A</sub> = 25°C

	PARAMETER	TEST CONDITIONS	MIN	TYP†	MAX	UNIT
<sup>t</sup> PHL	Propagation delay time, high- to low-level output	$V_{ID} = -1.5 V$ to 1.5 V,	11	22	30	ns
<sup>t</sup> PLH	Propagation delay time, low- to high-level output	See Figure 1	11	22	30	ns
<sup>t</sup> PZH	Output enable time to high level	See Figure 2		17	30	ns
t <sub>PZL</sub>	Output enable time to low level	See Figure 3		18	30	ns
<sup>t</sup> PHZ	Output disable time from high level	See Figure 2		30	40	ns
t <sub>PLZ</sub>	Output disable time from low level	See Figure 3		23	30	ns
t <sub>sk(p)</sub>	Pulse skew ( tpHL - tpLH )	See Figure 2		4	6	ns
tt	Transition time	See Figure 1		3	10	ns

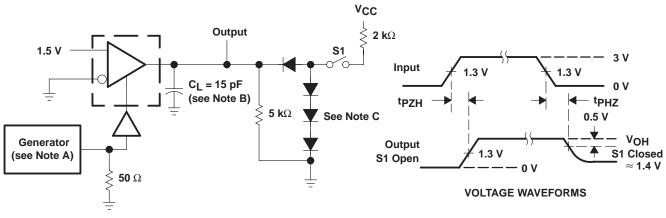


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#### PARAMETER MEASUREMENT INFORMATION







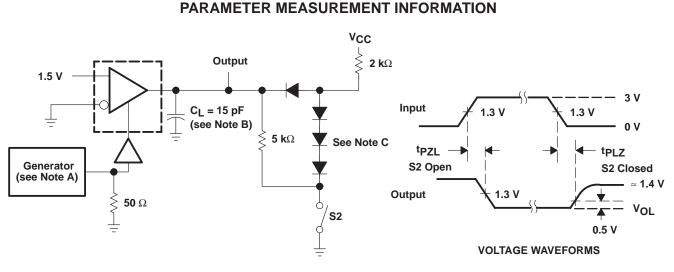
**TEST CIRCUIT** 

- NOTES: A. The input pulse is supplied by a generator having the following characteristics: PRR = 1 MHz, duty cycle = 50%,  $t_{f} \le 6$  ns,  $t_{f} \le 6$  ns,  $Z_{O} = 50 \Omega$ .
  - B.  $\dot{C}_L$  includes probe and jig capacitance.
  - C. All diodes are 1N916 or equivalent.

#### Figure 2. t<sub>PHZ</sub> and t<sub>PZH</sub> Test Circuit and Voltage Waveforms



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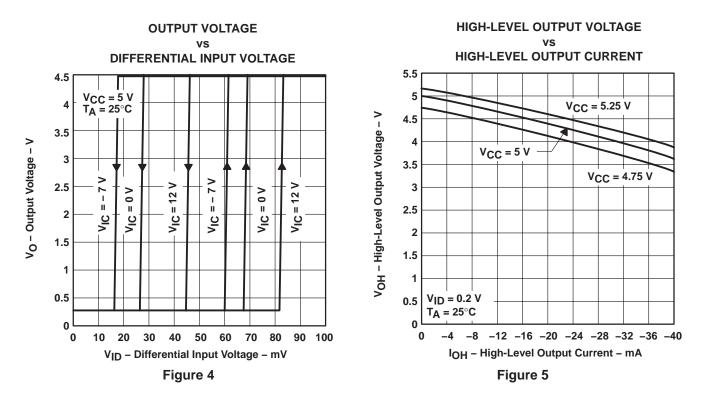


#### **TEST CIRCUIT**

- NOTES: A. The input pulse is supplied by a generator having the following characteristics: PRR = 1 MHz, duty cycle = 50%,  $t_{f} \le 6$  ns,  $t_{f} \le 6$  ns,  $Z_{O} = 50 \Omega$ .
  - B. CL includes probe and jig capacitance.
  - C. All diodes are 1N916 or equivalent.

#### Figure 3. tPZL and tPLZ Test Circuit and Voltage Waveforms

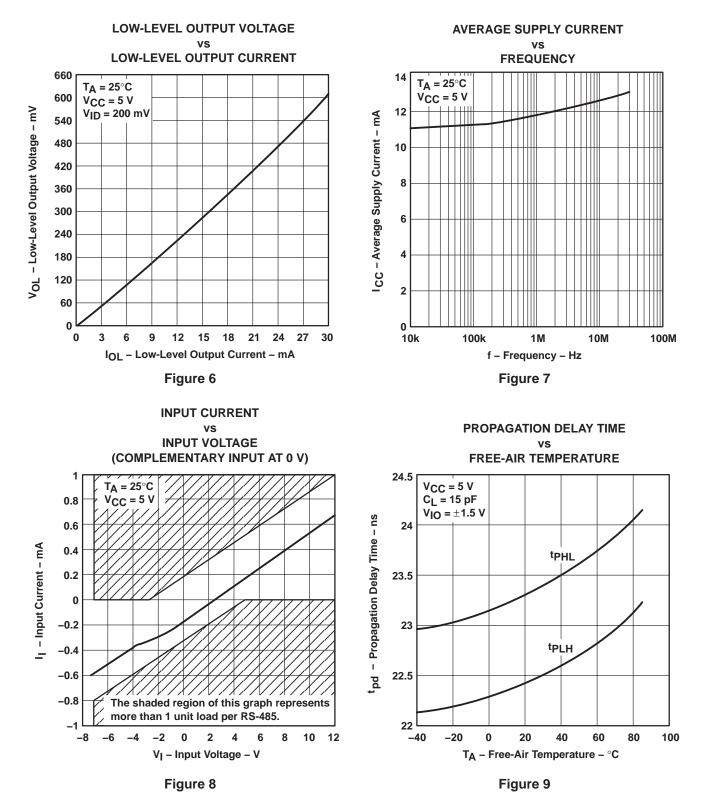






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#### **TYPICAL CHARACTERISTICS**







24-Aug-2018

### PACKAGING INFORMATION

Orderable Device	Status	Package Type	•	Pins	•	Eco Plan	Lead/Ball Finish	MSL Peak Temp	Op Temp (°C)	Device Marking	Samples
	(1)		Drawing		Qty	(2)	(6)	(3)		(4/5)	
SN65LBC175D	ACTIVE	SOIC	D	16	40	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 85	65LBC175	Samples
SN65LBC175DG4	ACTIVE	SOIC	D	16	40	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 85	65LBC175	Samples
SN65LBC175DR	ACTIVE	SOIC	D	16	2500	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 85	65LBC175	Samples
SN65LBC175DRG4	ACTIVE	SOIC	D	16	2500	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 85	65LBC175	Samples
SN65LBC175DW	ACTIVE	SOIC	DW	16	40	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 85	65LBC175	Samples
SN65LBC175DWG4	ACTIVE	SOIC	DW	16	40	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 85	65LBC175	Samples
SN65LBC175DWR	ACTIVE	SOIC	DW	16	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 85	65LBC175	Samples
SN65LBC175N	ACTIVE	PDIP	Ν	16	25	Green (RoHS & no Sb/Br)	CU NIPDAU	N / A for Pkg Type	-40 to 85	SN65LBC175N	Samples
SN75LBC175D	ACTIVE	SOIC	D	16	40	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	0 to 70	75LBC175	Samples
SN75LBC175DR	ACTIVE	SOIC	D	16	2500	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	0 to 70	75LBC175	Samples
SN75LBC175N	ACTIVE	PDIP	Ν	16	25	Green (RoHS & no Sb/Br)	CU NIPDAU	N / A for Pkg Type	0 to 70	SN75LBC175N	Samples

<sup>(1)</sup> The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

**PREVIEW:** Device has been announced but is not in production. Samples may or may not be available.

**OBSOLETE:** TI has discontinued the production of the device.

<sup>(2)</sup> **RoHS**: TI defines "RoHS" to mean semiconductor products that are compliant with the current EU RoHS requirements for all 10 RoHS substances, including the requirement that RoHS substance do not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, "RoHS" products are suitable for use in specified lead-free processes. TI may reference these types of products as "Pb-Free".

**RoHS Exempt:** TI defines "RoHS Exempt" to mean products that contain lead but are compliant with EU RoHS pursuant to a specific EU RoHS exemption.

Green: TI defines "Green" to mean the content of Chlorine (CI) and Bromine (Br) based flame retardants meet JS709B low halogen requirements of <= 1000ppm threshold. Antimony trioxide based flame retardants must also meet the <= 1000ppm threshold requirement.



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<sup>(3)</sup> MSL, Peak Temp. - The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

<sup>(4)</sup> There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.

<sup>(5)</sup> Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.

<sup>(6)</sup> Lead/Ball Finish - Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead/Ball Finish values may wrap to two lines if the finish value exceeds the maximum column width.

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#### OTHER QUALIFIED VERSIONS OF SN75LBC175 :

• Military: SN55LBC175

NOTE: Qualified Version Definitions:

• Military - QML certified for Military and Defense Applications

### PACKAGE MATERIALS INFORMATION

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#### TAPE AND REEL INFORMATION





#### QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



*All dimensions are nominal												
Device	Package Type	Package Drawing		SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
SN65LBC175DR	SOIC	D	16	2500	330.0	16.4	6.5	10.3	2.1	8.0	16.0	Q1
SN65LBC175DWR	SOIC	DW	16	2000	330.0	16.4	10.75	10.7	2.7	12.0	16.0	Q1
SN75LBC175DR	SOIC	D	16	2500	330.0	16.4	6.5	10.3	2.1	8.0	16.0	Q1

TEXAS INSTRUMENTS

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### PACKAGE MATERIALS INFORMATION

19-Jan-2015



\*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
SN65LBC175DR	SOIC	D	16	2500	333.2	345.9	28.6
SN65LBC175DWR	SOIC	DW	16	2000	367.0	367.0	38.0
SN75LBC175DR	SOIC	D	16	2500	333.2	345.9	28.6

### **DW 16**

## **GENERIC PACKAGE VIEW**

### SOIC - 2.65 mm max height

SMALL OUTLINE INTEGRATED CIRCUIT

7.5 x 10.3, 1.27 mm pitch

This image is a representation of the package family, actual package may vary. Refer to the product data sheet for package details.





## **DW0016A**



### **PACKAGE OUTLINE**

SOIC - 2.65 mm max height

SOIC



#### NOTES:

- 1. All linear dimensions are in millimeters. Dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
  This drawing is subject to change without notice.
  This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not
- exceed 0.15 mm, per side.
- 4. This dimension does not include interlead flash. Interlead flash shall not exceed 0.25 mm, per side.
- 5. Reference JEDEC registration MS-013.

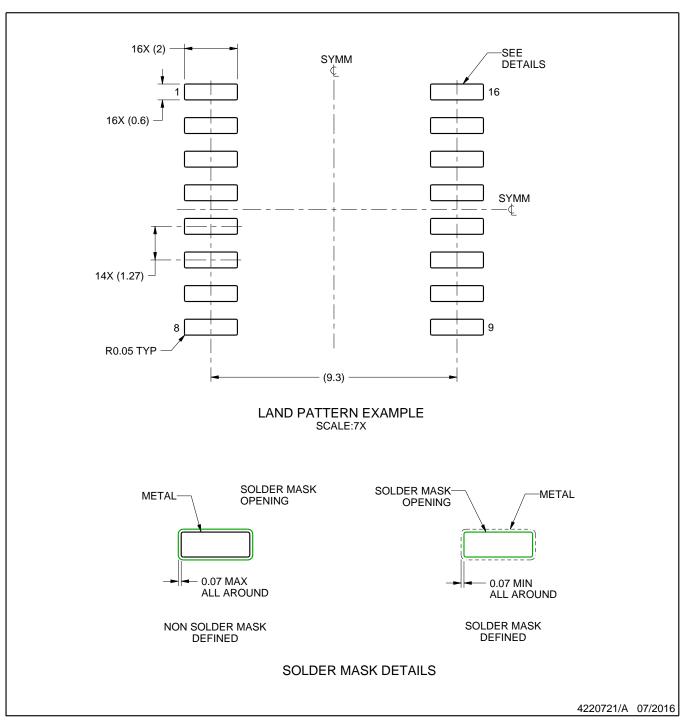


## DW0016A

## **EXAMPLE BOARD LAYOUT**

### SOIC - 2.65 mm max height

SOIC



NOTES: (continued)

6. Publication IPC-7351 may have alternate designs.

7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.



### DW0016A

## **EXAMPLE STENCIL DESIGN**

### SOIC - 2.65 mm max height

SOIC



NOTES: (continued)

8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.

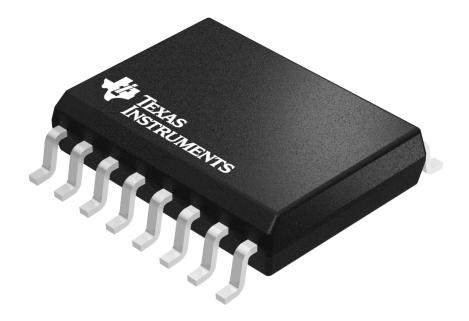
9. Board assembly site may have different recommendations for stencil design.



### **GENERIC PACKAGE VIEW**

## SOIC - 2.65 mm max height

SMALL OUTLINE INTEGRATED CIRCUIT



Images above are just a representation of the package family, actual package may vary. Refer to the product data sheet for package details.



4040000-2/H

### N (R-PDIP-T\*\*)

PLASTIC DUAL-IN-LINE PACKAGE

16 PINS SHOWN



NOTES:

- A. All linear dimensions are in inches (millimeters).B. This drawing is subject to change without notice.
- Falls within JEDEC MS-001, except 18 and 20 pin minimum body length (Dim A).
- $\triangle$  The 20 pin end lead shoulder width is a vendor option, either half or full width.



D (R-PDSO-G16)

PLASTIC SMALL OUTLINE



NOTES: A. All linear dimensions are in inches (millimeters).

- B. This drawing is subject to change without notice.
- Body length does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0.006 (0,15) each side.
- Body width does not include interlead flash. Interlead flash shall not exceed 0.017 (0,43) each side.
- E. Reference JEDEC MS-012 variation AC.



4211283-4/E 08/12

## D (R-PDSO-G16) PLASTIC SMALL OUTLINE Stencil Openings (Note D) Example Board Layout (Note C) –16x0,55 -14x1,27 -14x1,27 16x1,50 5,40 5.40 Example Non Soldermask Defined Pad Example Pad Geometry (See Note C) 0,60 .55 Example 1. Solder Mask Opening (See Note E) -0,07 All Around

NOTES: A. All linear dimensions are in millimeters.

- B. This drawing is subject to change without notice.
- C. Publication IPC-7351 is recommended for alternate designs.
- D. Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers should contact their board assembly site for stencil design recommendations. Refer to IPC-7525 for other stencil recommendations.
   E. Customers should contact their board fabrication site for solder mask tolerances between and around signal pads.



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